Resolution of Resonances in a General Purpose Quantum Device Simulator

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Electron transport in quantum devices is governed by discrete quantum states due to electron confinement. A crucial requirement for the modeling of quantum devices is the the numerical identification and resolution of these quantum states. We present an algorithm utilized in our general purpose quantum device simulator, where we locate the resonances of the system first and then generate the optimized grid used to integrate over the resonances. We find this algorithm important in the modeling of coherent transport involving ultrafine resonances and crucial for the modeling of incoherent transport.

I. INTRODUCTION

One major problem in the development of a high bias current-voltage simulator for quantum devices is the resolution and treatment of resonant states. The resonance states strongly influence the transmission through and the scattering in the device. To calculate observables like the current and the charge at high bias we have to integrate in energy (and/or momentum) over these resonances. These resonance states are as sharp as 1 neV-5 meV in an energy range of 0-1000 meV spanned by the applied bias. A homogeneous energy grid resolution of $1 \mu \text{eV}$ over an energy range of 1000 meV would require 1,000,000 nodes which is unfeasible for our purposes, where a single integration point may be very expensive to compute, or the storage of all integration points is necessary. Since there are only few sharply varying features the numerical analysis should be carried out on a well optimized inhomogeneous energy grid. In addition to the sharp quantum features we have to resolve more smoothly varying features such as the lead carrier distributions of 5 meV-50 meV with a temperature dependent modulation 0.3 meV-25 meV. Figure (1a) illustrates these spectral features for the case of a typical resonant tunneling diode.

II. PROBLEMS WITH THE STANDARD PROCEDURE

The standard¹ solution to this problem of integration over sharply varying integrands is the successive partitioning of the integration range. An adaptive grid is constructed by adding nodes within the integration range of interest as a test of the integration convergence. While this trial and error method is foolproof as long as the convergence criteria are stringent enough, it does have 2 conceptual drawbacks.

- 1. The optimization is based on a relative error analysis. I.e. the improvement of the integrand due to adding a node is measured in the small integration segment, rather than the overall integral. The requested relative accuracy is therefore not in direct relation to the absolute accuracy of the integral. The procedure will resolve curvature features well, however it will also place many nodes in energy ranges where the total integral contribution is insignificant. An optimization procedure minimizing the absolute error is more desirable to avoid the calculation of insignificant integral contributions.
- 2. Nodes are added as a pure test whether they are needed for the integration or not. Adding nodes in an integration can complicate algorithms dramatically, if other quantities which depend on the integral and modify the integrand are to be updated as well. For vectorization purposes we prefer to deal with fixed grids.

III. THE NEW ALGORITHM

The expensive task in the sucessive partitioning approach is the locating of the resonances. If we would know where the resonances were, we could conceive of a method to place an inhomogeneous grid smartly. Resonance finding algorithms for single band² and multi band³ have been developed and we use them as part of our fixed grid generation. These algorithms return the eigenvalues $(E_r - i,)$ of the single electron tight binding Hamiltonians describing the quantum device. The location, E_r , and width, , , of the resonant states in the device lays the foundation for the generation of a grid that resolves these features well.

For numerical stability in terms of round off errors we would like the integration contribution from one energy node to the next to be about the same. This suggests a very simple scheme which lets us optimize the energy grid with

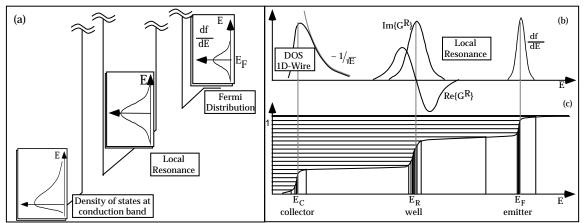


FIG. 1. Construction of an inhomogeneous energy grid using the location of spectral features. (a) Schematic conduction band profile of a resonant tunneling diode. The inserted panels indicate the spatial and energetic location of spectral features that we wish to resolve: localized resonances, Fermi factors and conduction band edges. (b) Spectral features on one energy axis. In addition to (a) we show the real part of the retarded Green function (principal value integral of a Lorentzian). (c) The single spectral features in (b) can be integrated analytically to obtain a monotonic function. An optimized inhomogeneous energy grid can be obtained by projecting a homogeneous grid from the y-axis of the monotonic function onto the energy axis. The projection scheme to obtain a fixed energy grid was inspired by class notes of Prof. J. Gray in the School of Electrical Engineering at Purdue University.

respect to integral quantities. The integral over a spiked function is a monotonic increasing function. Figure (1b) indicates how a homogeneous grid on the abscissa of a monotonic function projects to an inhomogeneous grid on the ordinate. The question now remains how we get the monotonic functions of the right shape.

Close to the resonance we can approximate the density of states $-\frac{1}{\pi}\mathcal{I}\mathcal{M}G^R$ where G^R is the retarded Green function by a Lorentzian at energy E_r and width , . The real part of G^R is proportional to the principal value integral of that Lorentzian. The integral over the Lorentzian function and the principal value integral can be performed analytically resulting in monotonic functions $m_{IM}(E)$ and $m_{RE}(E)$. The real part of G^R is doubly peaked at $E_r \pm \frac{\Gamma}{2}$. We enhance the resolution of the resonance by placing two monotonic contributions m_{RE-IM} corresponding to $m_{IM}(E)$ at the energies $E_r \pm \frac{\Gamma}{2}$ with a width , $'=(\sqrt{3}-1)\frac{\Gamma}{2}$.

IV. OTHER SPECTRAL FEATURES

Several other spectral features need to be resolved as well, aside from the sharply peaked resonances. The density of states around the conduction band edge varies sharply with respect to energy. We have optimized this turn-on using three different distributions: 1) a $1/\sqrt{E}$ distribution convolved with a Lorentzian, 2) a triangular distribution, and 3) a homogeneous distribution around the conduction band edge. We find that the homogeneous contribution around the conduction band edge provides an adequate resolution of the density of states at the conduction band edge. The integral contributions to the density of states at the band edges is modeled by the monotonic function $m_{band-edge}$. The variations in the Fermi occupation factor, f, in the contacts are resolved in a similar manner noting that $m_{fermi} = 1 - f$ is an analytic and monotonic growing function. To resolve turn-ons of the Fermi distribution we optimize the energy grid with respect to the fourth derivative of f resulting in another monotonic contribution m_{fermi} . Given the individual contributions we can build an analytic monotonic function $m(E) = x_1 m_{IM}(E) + x_2 m_{RE}(E) + x_3 m_{RE-IM}(E) + x_4 m_{band-edge} + x_5 m_{fermi} + x_6 m_{fermi}$ where x_i are weighing parameters. The monotonic function m(E) can be evaluated "cheaply" for any E and can be inverted to a homogeneous grid in f in f numerically.

V. PERFORMANCE CHECK

As a comparison we perform here the integration over the real and the imaginary part of 2 narrow resonances $(, = 0.5 \mu eV)$ at $E_r = 100 meV$ and $E_r = 300 meV$ placed in a wide energy range of 1000 meV (see inset of figure (2a)). We perform the numerical integration in four different schemes: 1) our new fixed energy grid with trapezoidal integration (see Fig. (2a)), 2) our new fixed energy grid with Simpson integration (see Fig. (2b,c)), 3) a typical adaptive grid scheme with trapezoidal integration (see Fig. (2a,b)), and 3) a typical adaptive grid scheme with Simpson integration (see Fig. (2c)). Figure (2) shows clearly that we typically obtain a savings of integration nodes

of a factor of $k \approx 4-10$. Depending on the calculation that has to be performed the number of operations may scale as $k^1 - k^3$ and the required memory scales as $k^1 - k^2$.

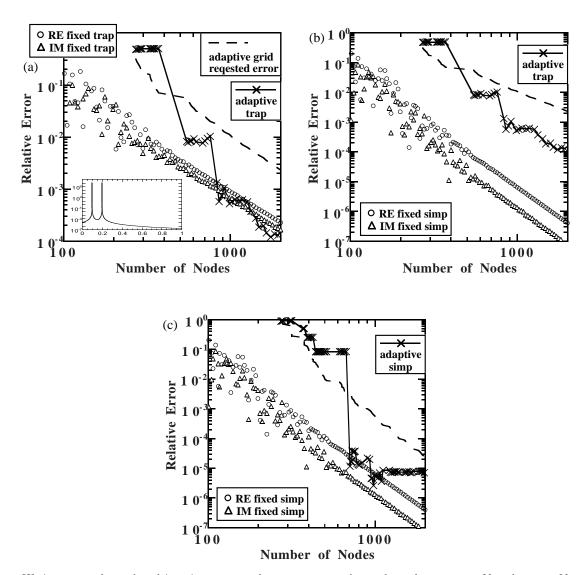


FIG. 2. We integrate the real and imaginary part of two resonances located at about 100 meV and 300 meV, respectively, each with an energy width of $0.5~\mu\text{eV}$. The energy range of integration is 0-1 eV (see inset in a). (a) trapezoidal integration using the fixed and the adaptive grid. The dashed line indicates the requested relative accuracy of the adaptive grid. (b) Simpson integration using the fixed grid compared to trapezoidal integration on an adaptive grid. (c) Simpson integration with the fixed grid and the adaptive grid. For the fixed grid we show the relative errors of the imaginary part and the real part integral separately. For the adaptive grid approaches we show the maximum error. The dashed lines indicate the relative precision specified in the adaptive grid approaches.

The drawback of the adaptive schemes are that they have to "home in" on the resonances, which pushes the number of integration nodes up. The drawback of the fixed energy grid scheme described here is that we have to perform the resonance finding first. Single band resonance finding² scales as N^2 and multiband resonance finding³ scales superlinear in N where N is the number of tight binding spatial nodes in the device. The recursive Green function algorithm⁴ which can deliver the density of states and the transmission throughout the device scales as N. For the modeling of coherent transport⁵ with not too sharp resonances (, > $1\mu eV$) we find the adaptive grid optimization outperformes the fixed energy grid scheme including resonance finding. However in cases where the resonances are very sharp (, < $1\mu eV$) our new scheme outperforms the usual adaptive scheme. For the modeling of incoherent transport⁶ where we include acoustic and polar optical phonons, alloy disorder scattering and interface roughness scattering we find our fixed energy grid scheme essential. In this case we have to perform multidimensional, coupled integrals, where intermediate results have to be stored and we find ourselves severely limited by memory requirements of 400-500MB on a workstation. Another drawback of the fixed grid scheme presented here is that the integration accuracy cannot be specified a priori. Note, however that the relative accuracy specified in the standard adaptive schemes does not

correspond to the absolute accuracy (Fig. 2). The standard adaptive scheme can easily miss resonances completely and it often turns out to be an "all or nothing approach". With respect to accuracy we sometimes find it useful to mix the two approaches, where the fixed grid serves as a starting point of adaptive grid integration.

VI. ACKNOWLEDGEMENTS

The presented projection scheme to obtain a fixed energy grid is inspired by class notes of Prof. J. Gray in the School of Electrical Engineering at Purdue University.

VII. BIOGRAPHIES

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